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Serial No. 09/942,131
Information Disclosure Statement

Foreign Patent Documents			
Exam. Initials	Document No.	Date	Country
C.S	0 380 904	02/01/1989	Europe
C.S	0 731 371	03/06/1995	Europe

Other Documents	
Exam. Initials	Description (Author, Title, Date, Pages, etc)
C.S	D.W. Schiering, et al., "An FTIR microscope", <u>American Laboratory</u> : 33, pp. 26-40. Nov. 1990
	European Search Report

The listed patents pertain in a general way to the subject matter of the application, but are not necessarily considered to be analogous prior art.

Respectfully submitted,

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Date Considered

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Examiner